

A Compact Microstrip Crossover Based on Capacitively-Loaded Artificial Transmission Lines Branch-Line Sections

Jordi Verdu^{*}, Endika Bernaola, and Pedro de Paco

Abstract—This paper presents a compact size crossover device based on the cascade of branch-line sections. With the aim of reducing its size, some of the transmission lines of the structure have been replaced by its equivalent artificial transmission line (ATL). The obtained size reduction is above 30%, and the electrical performance of the proposed structure presents an isolation better than 20 dB in a $FBW = 34.5\%$ and a crossover bandwidth better than 2 dB of $FBW = 51.5\%$. Also the good magnitude and phase balance performance must be highlighted.

1. INTRODUCTION

The design of microstrip circuits in the range of microwave frequencies normally requires the cross between two lines with high isolation between them, which is commonly known as crossover [1]. Traditionally, the crossover of signals was achieved by means of air bridges or multilayer substrates [1, 2]. However, the fabrication processes for those non-planar structures present a big complexity and also increase the cost. On the other hand, the use of a branch-line coupler has also been proposed in a crossover design, as it is the case of the work in [3], where a dual-band planar crossover is achieved using a two-section branch-line structure. The cascade of branch-line sections also allows the achievement of a better operation bandwidth as discussed in [4], where structures with several sections are presented to demonstrate the concept; however, the impedance of the RF ports is different from the 50 Ohm reference impedance. This situation requires phase control on the reflection coefficient, and it may cause matching problems when it must be connected to other systems. In this work, a compact crossover based on the cascade of branch-line couplers is proposed. Here, the access RF ports are matched to the reference impedance. In order to obtain a compact structure, the transmission lines of the structure are replaced by capacitively-loaded artificial transmission lines (ATL) [5] resulting in a significant size reduction. This area minimization allows the inclusion of an extra section in order to improve the bandwidth performance substantially.

2. THEORETICAL ANALYSIS

The proposed basic structure for the crossover is shown in Fig. 1. The structure consists of the cascade of a 4-section branch-line coupler which is a good tradeoff between occupied size and achievable transmission bandwidth. Taking into account the symmetry plane given by A-A' and B-B', the odd-even mode analysis can be carried out, where the scattering parameters of the structure can be expressed as a function of the even and odd components [6],

$$\begin{aligned}
 s_{11} &= \frac{\Gamma_{ee} + \Gamma_{eo} + \Gamma_{oe} + \Gamma_{oo}}{4} & s_{21} &= \frac{\Gamma_{ee} - \Gamma_{eo} + \Gamma_{oe} - \Gamma_{oo}}{4} \\
 s_{31} &= \frac{\Gamma_{ee} - \Gamma_{eo} - \Gamma_{oe} + \Gamma_{oo}}{4} & s_{41} &= \frac{\Gamma_{ee} + \Gamma_{eo} - \Gamma_{oe} - \Gamma_{oo}}{4}
 \end{aligned} \tag{1}$$

Received 14 April 2017, Accepted 20 May 2017, Scheduled 19 June 2017

^{*} Corresponding author: Jordi Verdu Tirado (jordi.verdu@uab.cat).

The authors are with the Telecommunications and Systems Engineering Department, Universitat Autònoma de Barcelona (UAB), Spain.

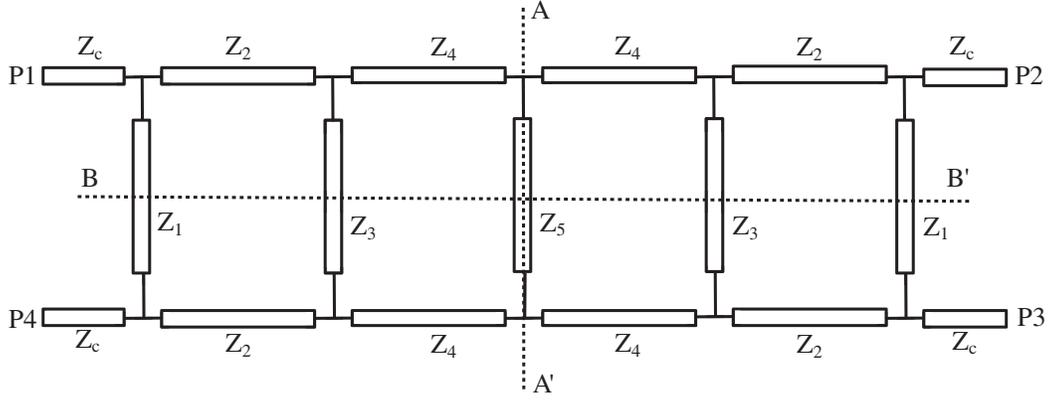


Figure 1. Crossover basic topology based on the cascade of 4-section branch line couplers.

where

$$\Gamma_{ee, eo, oe, oo} = \frac{Y_0 - Y_{ee, eo, oe, oo}}{Y_0 + Y_{ee, eo, oe, oo}} \quad (2)$$

Y_0 is the reference admittance, and Y_{ee} , Y_{eo} , Y_{oe} , and Y_{oo} are the input admittances of each reduced network. The analysis of the different four subnetworks given by the symmetry of the structure results in the next even and odd admittances,

$$\begin{aligned} Y_{ee} &= \frac{j(Z_4^2(Z_1Z_3 - Z_2^2) + 2Z_5Z_2^2Z_3)}{Z_1Z_2^2(2Z_5Z_3 - Z_4^2)}; & Y_{eo} &= -\frac{j(Z_1Z_3 - Z_2^2)}{Z_1Z_2^2} \\ Y_{oe} &= -\frac{j(Z_4^2(Z_1Z_3 - Z_2^2) + 2Z_5Z_2^2Z_3)}{Z_1Z_2^2(2Z_5Z_3 - Z_4^2)}; & Y_{oo} &= \frac{j(Z_1Z_3 - Z_2^2)}{Z_1Z_2^2} \end{aligned} \quad (3)$$

In order to obtain the design equations, perfect matching and isolation are required, so $S_{11} = S_{12} = S_{14} = 0$. The passive and lossless characteristics of the structure entail the crossover state, i.e., $S_{13} = 1$. By a proper combination of equations in Eq. (4) to accomplish the matching and isolation conditions, we can obtain the next relations,

$$\Gamma_{ee} + \Gamma_{oe} = 0; \quad \Gamma_{ee} + \Gamma_{eo} = 0; \quad \Gamma_{ee} - \Gamma_{oo} = 0; \quad (4)$$

However, from the analysis of the structure $\Gamma_{eo} = -\Gamma_{oo}$, the set of conditions in Eq. (4) is reduced to two equations. Using Eqs. (3) and (4), we can fix the values of impedances Z_1 and Z_3 . On the other hand, assuming the symmetry of the structure, we can force the condition $Z_1 = Z_5$. Therefore, the values of the impedances can be calculated as,

$$\begin{aligned} Z_1 = Z_5 &= \frac{Z_0Z_2^2}{Z_3 + Z_2^2} \\ Z_3 &= Z_0 \left(\frac{Z_4^2}{2} - Z_2^2 - \frac{\sqrt{(Z_4^4 + 4Z_2^4)}}{2} \right) \end{aligned} \quad (5)$$

At this point, we have defined three out of the five required impedances. In order to obtain the values of Z_2 and Z_4 , an algorithm is developed, which calculates the impedance set for the maximum achievable isolation bandwidth, for a level below 20 dB, as a function of frequency. The obtained maximum bandwidth is found to be around 35%, in agreement with the results in [4], although in this work, port access lines with reference impedance $Z_0 = 50 \Omega$ are used. The design center frequency is $f_0 = 2.5$ GHz. A fine tuning in the impedance values is carried out to have a better balance in the obtained performance. These values are listed in Table 1.

Table 1. Impedance values for the basic structure.

Z_c	Z_1	Z_2	Z_3	Z_4	Z_5
50Ω	93.2Ω	40.3Ω	54.1Ω	46.7Ω	84.2Ω

2.1. Compact Structure Based on ATL Lines

With the aim of reducing the size of the circuit, artificial transmission lines (ATL) are used [5]. Fig. 2 shows the scheme of the proposal, where a transmission line is divided in cells (dashed square), loading each with a capacitance C_p or its equivalent using open-circuit stubs. By doing this, the effective length of the transmission line can be significantly reduced. This technique is valid when the dimension of the cell (d_{ATL} and l_{Stub}) are much smaller than the wavelength, which is approximately less than $\lambda/10$.

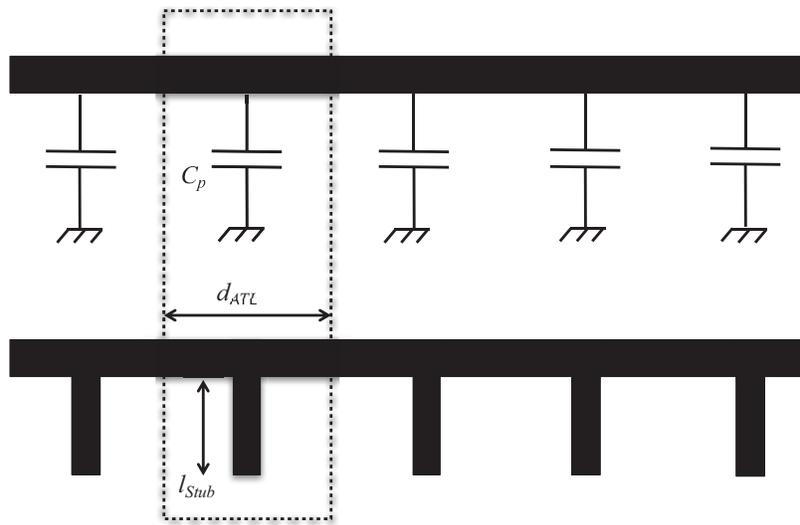


Figure 2. Stub-loaded Artificial Transmission Line (ATL).

The basic cell of a transmission line given by R , L and C is first considered, where capacitance C_p is in shunt with C at each cell. Therefore, the characteristic impedance and phase velocity of the ATL cell can be calculated as,

$$Z_{0ATL} = \sqrt{\frac{L}{C + \frac{C_p}{d_{ATL}}}}; \quad v_{pATL} = \frac{1}{\sqrt{L \left(C + \frac{C_p}{d_{ATL}} \right)}} \quad (6)$$

d_{ATL} being the length of the cell which determines the periodicity of the structure. Therefore, the value of d_{ATL} can be calculated for a given number of sections N , and the electrical length of the transmission line must be equal to the electrical length of the ATL line ϕ_{ATL} . Thus, the size of the cell can be determined as,

$$d_{ATL} = \frac{Z_{0ATL} \phi_{ATL} v_{pATL}}{Z_0 N \omega_0} \quad (7)$$

where Z_0 corresponds to the characteristic impedance of the transmission line.

The value of capacitance C_p can be obtained by the combination of Equations (6) and (7). The equivalence between a shunt capacitor and shunt open-circuit stub is very well known. Therefore, the length of the stub l_{Stub} can be obtained from the C_p value since,

$$\omega_0 C_p = \frac{1}{Z_{0Stub}} \tan \left(\frac{\omega_0}{v_{pStub}} l_{Stub} \right) \quad (8)$$

where Z_{0Stub} and v_{pStub} are the characteristic impedance and phase velocity of the stub transmission lines. The width of the stub line is related with the width of the main ATL transmission line, which at the same time is related to the number of sections N . As a design rule, it is desirable that the space between stub lines is less than $3h$, h being the substrate thickness, in order to avoid undesirable couplings. With this consideration, the rest of the parameters may be chosen depending on the design and technological limitations. For example, the use of a lower impedance of the main ATL line leads to a lower value of l_{Stub} for the stub but a higher value of d_{ATL} , which is not desired for the size reduction. In case that the obtained value of l_{Stub} is too high, one solution consists in including open-circuit stubs on both sides of the transmission line. By doing this, the total capacitance per cell is reduced to half, leading to an extra length reduction.

3. FABRICATION AND MEASUREMENT

The proposed device, shown in Fig. 3, is fabricated on a Rogers4003 substrate, with relative permittivity $\epsilon_r = 3.38$, thickness $h = 508 \mu\text{m}$ and loss tangent $\delta = 0.0027$. The dimensions of the device, as well as the used sections, are shown in Table 2. As can be seen, neither Z_1 nor Z_5 is replaced by its equivalent ATL line since the resulting width leads to a technological constraint. The solution is to use a simple meander taking advantage of the available space. The lines with Z_2 and Z_4 are substituted by an ATL line with $N=5$ sections, while $N = 3$ sections are used for the equivalence of the line with Z_3 . The resulting size of the proposed device presents a size reduction of 30.5% in terms of λ compared with the 4-sections device in [4].

Table 2. Proposed device dimensions.

	Z_c	Z_1	Z_2	Z_3	Z_4	Z_5
N	-	-	5	3	5	-
W_{TL} [mm]	1.152	0.334	0.5	0.5	0.5	0.43
d_{ATL} [mm]	18.3	19.21	1.93	4.349	2.252	19.07
W_{Stub} [mm]	-	-	1	0.7	0.8	-
l_{Stub} [mm]	-	-	3.60	3.9	3.13	-

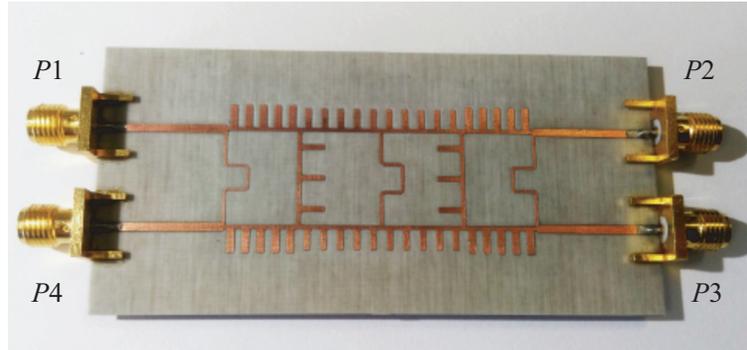


Figure 3. Resulting fabricated device.

The measured S -parameters are shown in Fig. 4. From the point of view of matching and isolation, the fabricated device presents a rational bandwidth $FBW = 46.5\%$ for the matching, and $FBW = 34.5\%$ for the isolation between ports 1 and 2, for 20 dB specifications. If the obtained performance is compared with $N = 2$ sections, which occupies an equivalent area, the achievable bandwidth increases from 9% to 34.5%. For the crossover, the obtained rational bandwidth is $FBW = 51.5\%$ with insertion loss less than 2 dB. It must also be highlighted that the proposed structure

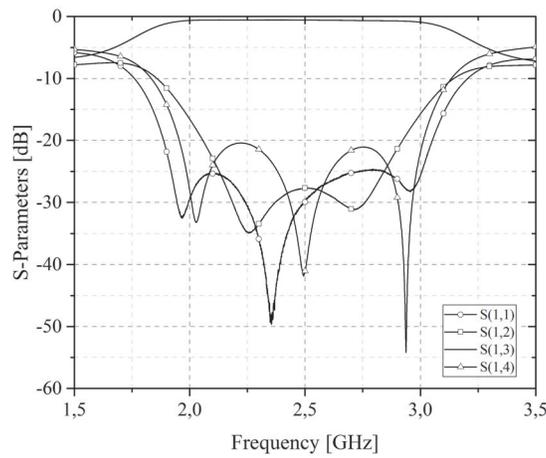


Figure 4. Measured *S*-parameters of the proposed device.

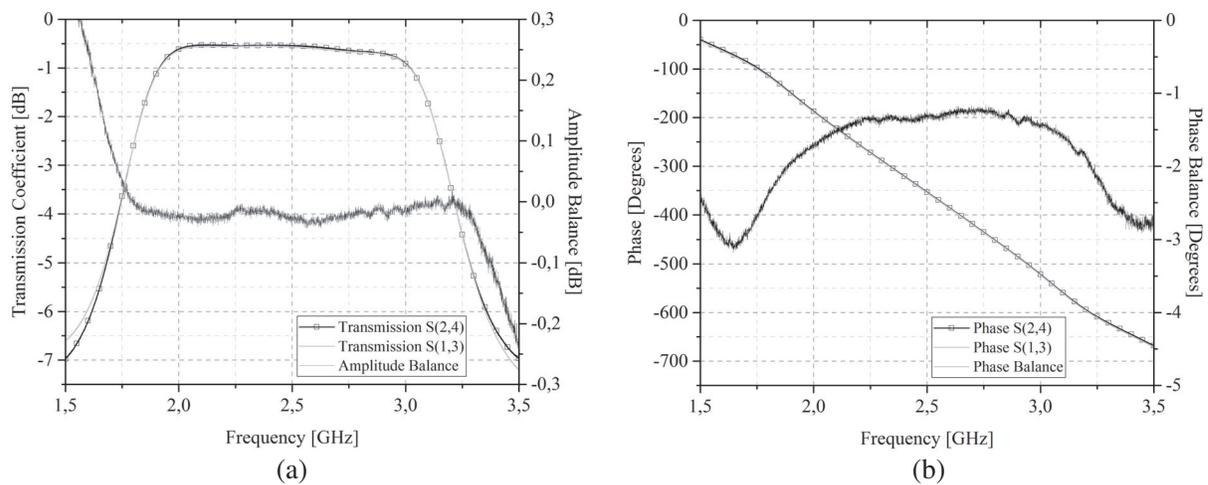


Figure 5. (a) Measured magnitude balance and (b) phase balance between RF ports 1-3 and 2-4.

Table 3. Size reduction comparison with the 4-sections device in [4].

		Including Access Port	Omitting Access Port
Device in [4]	(Width × Height) [mm]	106.1x24.1	71.15x24.1
	(Width × Height) [λ]	0.88 λ × 0.2 λ	0.59 λ × 0.2 λ
	Total area [mm ²]	2557.01	1717.56
Proposed Compact Design	(Width × Height) [mm]	83.7x22.6	46.9x22.6
	(Width × Height) [λ]	0.69 λ × 0.18 λ	0.39 λ × 0.18 λ
	Total area [mm ²]	1891.62	1059.94
Area Reduction		26.02%	38.28%

presents a wide-band performance in terms of magnitude and phase balance in the crossover state. In this case, as shown in Fig. 5, the obtained relative bandwidth for a difference below ± 0.05 dB is $FBW = 63.5\%$ (Top), while for a phase balance below 2° it is $FBW = 55.1\%$ (Bottom). Table 3 shows the comparison, from the size point of view, between the 4-section branch-line design developed in [4] and the compact structure developed in this work. It must be highlighted that the access lines in [4] are not designed at $Z_c = 50 \Omega$; therefore, the direct comparison is not appropriate. However, with the aim of having a clearer idea, the comparison is shown if these access lines are considered, or if they are omitted. The obtained size reduction is 26.02% in the case of considering such lines, or 38.28% if they are omitted.

4. CONCLUSIONS

A compact microstrip crossover based on the cascade of N branch-line sections is proposed. In order to get a size reduction, the transmission lines of the structure are replaced by their equivalent Artificial Transmission Line (ATL), achieving a size reduction of 30% with respect the conventional structure. To do this, the theoretical development is shown, as well as the required design equations. The electrical performance of the proposed device presents a $FBW = 34.5\%$ in terms of isolation and 51.5% in the crossover state. The observed performance in terms of magnitude and phase balance must also be highlighted. In the first case, $FWB = 58\%$ for the magnitude balance, and $FBW = 31.2\%$ for the phase balance.

ACKNOWLEDGMENT

This work was supported in part by the Spanish Ministerio de Economía y Competitividad under grant TEC2015-69229-R.

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